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Room-temperature ferromagnetism in Ca and Mg stabilized cubic zirconia bulk samples and thin films prepared by pulsed laser deposition

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Abstract

We report room-temperature ferromagnetism in Ca and Mg stabilized zirconia bulk samples and thin films. Powders were prepared by the citrate-combustion route, and thin films grown on silicon substrates by the pulsed laser deposition technique. X-ray diffractograms and Raman spectra at room temperature reveal the formation of cubic phase zirconia. The observed ferromagnetism is robust at room temperature in both bulk as well as in thin film samples, although it is weaker in thin films. The origin of the ferromagnetism can be related to oxygen vacancies created due to divalent (calcium and magnesium) substitution for tetravalent zirconium ions.

(Some figures may appear in colour only in the online journal)

1. Introduction

Dilute magnetic semiconductors (DMS) have attracted vast interest in the last decade because of the possibility of assembling charge and spin degrees of freedom in a single substance. That makes them promising candidates for technological applications in spintronic devices, utilizing both the electronic charge as well as their spins [1–3]. With this hope to realize spintronic devices such as spin valves, spin transistors, spin light-emitting diodes (LEDs), ultrafast optical switches, etc, a significant amount of research effort has been focused on discovering materials suitable for these applications. A large number of transition metal (TM) doped oxides have been examined since the first prediction of ferromagnetism in Mn-doped ZnO by Dietl \textit{et al} in 2000 [2]. A remarkable amount of research has been carried out to understand the nature of magnetism in TM-doped oxide systems, such as ZnO, TiO\textsubscript{2}, HfO\textsubscript{2}, CeO\textsubscript{2}, SnO\textsubscript{2} and In\textsubscript{2}O\textsubscript{3} [4–9]. However, the experimental search for ferromagnetism in TM-doped oxide materials has not yet resulted in reproducible and homogeneous magnetic materials.

Interestingly, ferromagnetism has been suggested to be possible even in systems that do not contain magnetic impurities, materials often referred to as \textit{d}\textsuperscript{0} or intrinsic ferromagnets [10, 11]. Experimentally, it has been shown that thin films of HfO\textsubscript{2} and ZnO [12, 13] exhibit such type of ferromagnetism with a rather high Curie temperature (\textit{T}\textsubscript{C}). The ferromagnetism with high Curie temperature was also proposed by substitution of the four-valent cation $A^{4+}$ in dioxides such as AO\textsubscript{2} ($A = Ti$, Zr, or Hf) by a monovalent cation of group 1A of the periodic table [11]. HfO\textsubscript{2} and ZrO\textsubscript{2} are both wide-band insulating materials with a high dielectric constant; the possibility of making them ferromagnetic could widen their possible application in the emerging field of spintronics.

Recent theoretical studies also predicted high-temperature ferromagnetism in TM-doped cubic zirconia [14] and K-doped ZrO\textsubscript{2} [11]. However, doping with Cu [15], Cr [14] or Ca...
Mn₃O₄ segregates on high-temperature heat treatments. To dope ZrO₂, a few experimental works have been carried out to confirm the room-temperature ferromagnetism in Zr₁₋ₓMnₓO₂ [16–18] and Zr₁₋ₓFeₓO₂ [19]. However, experimental results were controversial in these studies, and ferromagnetism was not shown up to the level, which has been predicted. Our recent experimental study on Mn-doped ZrO₂ [17] suggested that an undesired secondary phase like Mn₃O₄ segregates on high-temperature heat treatments. To overcome the problems related to secondary phases, we study the target 7.5 cm. Ca-doped ZrO₂ thin films were deposited at three different oxygen pressures in the chamber during the film growth: 10⁻², 10⁻³ and 10⁻⁴ mbar. The number of laser impulses for growing each film were 30000 and the resulting thicknesses of the films were ~150 nm.

The x-ray diffraction technique (Rigaku Ultima IV) and Raman spectroscopy (Horiba Jobin Yvon LabRAM HR 800) were used for structural identification at room temperature, whereas magnetic measurements were performed using a vibrating sample magnetometer (14 T PPMS-Quantum Design). Scanning electron micrographs (SEM) for microstructure and energy dispersive spectroscopic (EDS) measurements for stoichiometry were also made for those samples using a Zeiss EVO-MA15 apparatus.

3. Results and discussion

X-ray diffraction patterns for the undoped as well as Ca- and Mg-doped ZrO₂ bulk samples, heated at different temperatures are shown in figure 1(a). From these diffractograms we see that 16 at% Ca- and 14 at% Mg-doped ZrO₂ samples sintered at 1500 °C exhibit a pure cubic (C) zirconia phase. The undoped sample sintered at 800 °C shows a monoclinic structure with an extra peak of tetragonal zirconia, whereas a single-phase monoclinic structure is exhibited by the sample sintered at 1500 °C. The lower, 10 at% Ca-doped zirconia sample shows a mixed cubic and tetragonal (T) structure; the presence of the tetragonal structure in this sample is also confirmed by the Raman spectra (figure not included).

Figure 1(b) shows the diffractograms for the PLD thin films of the 16 at% Ca-doped ZrO₂, grown at different oxygen partial pressures. The films show one XRD peak for cubic zirconia (111) and other intense peaks from the silicon substrate. Raman spectra (see figure 2(b)) also confirm the cubic phase formation for thin films showing a characteristic cubic XRD pattern.

Raman spectra measured at room temperature for the bulk and thin film samples of doped zirconia are shown in figures 2(a) and (b). The spectrum for 16 at% Ca-doped ZrO₂ sintered sample at 1500 °C (figure 2(a)) validates the cubic phase formation (Raman peaks around 275, 410, 520 and 580 cm⁻¹) [22], whereas the peaks are not separable for both Ca and Mg stabilized zirconia samples heated at 800 °C. These broad and flat spectra may be related to the mixed zirconia phases at 800 °C, although XRD could show single phase for those powders. Usually, the strongest Raman peak position is around 615 cm⁻¹ for yttria-stabilized zirconia samples [22], but for Ca-stabilized zirconia this shifts towards lower values, and it is around 580 cm⁻¹ in our sample. This shift may be because of the difference in sizes and mass of Ca and Zr, as compared with Y and Zr [22]. Raman spectra for the PLD thin films of 16% Ca-doped ZrO₂ demonstrate characteristic peaks of cubic zirconia (155, 425, 620 cm⁻¹); the strong peaks due to the silicon substrate (near 300 and 530 cm⁻¹) can also be seen in the spectra that suppress the
Figure 1. XRD patterns of (a) bulk powders heat-treated at different temperatures, (b) 16% Ca-doped ZrO$_2$ thin films deposited at various oxygen partial pressures.

Figure 2. Room-temperature Raman spectra of (a) bulk samples of doped ZrO$_2$; (b) Zr$_{0.84}$Ca$_{0.16}$O$_2$ thin films.

The intensity of zirconia modes. Our results are consistent with another Raman study by Gazzoli et al [23], which showed that above 14% calcium doping stabilizes the cubic zirconia phase and below this doping concentration it results in a tetragonal structure; we have also observed the Raman spectra resembling the tetragonal structure for 10 at% Ca$^{2+}$ in ZrO$_2$ (figure not included).

SEM micrographs and EDX spectra of the undoped and doped zirconia samples sintered at different temperatures are shown in figure 3. The EDX spectra reveal that the chemical compositions are in good agreement with the desired stoichiometry, and there are no impurities in the prepared samples. From the SEM images we can visualize that all those samples have grains in the micrometre ($\mu$m) range; however, the grains are smaller ($\sim$2–5 $\mu$m) for the samples treated at 800 °C and the undoped sintered sample at 1500 °C, whereas the grains are in the range 3–8 $\mu$m for the doped sintered samples at 1500 °C.
Figure 3. SEM micrographs and EDX spectra of the undoped and doped zirconia samples.

Hysteresis loops measured at room temperature (300 K) for the Ca- and Mg-doped and undoped ZrO₂ samples heated at 800 and 1500 °C are shown in figure 4. $M\cdot H$ loops of the doped zirconia samples appear like a good ferromagnet for the powders heated at 800 °C, whereas the diamagnetism is enhanced in samples sintered at higher temperatures. The enhancement of the diamagnetic signal in the sintered samples may be due to the decrease in the number of oxygen vacancies on high-temperature treatment in air. The coercivities and spontaneous magnetization (at 0.5 T) estimated from these curves are listed in table 1. There are no remarkable changes in coercivities, whereas the saturation magnetization decreases with the increase in sintering temperatures. The undoped ZrO₂ samples also exhibit tiny ferromagnetic hysteresis, possibly
Figure 4. As-measured ($T = 300$ K) hysteresis loops of Ca- and Mg-doped ZrO$_2$ bulk samples heated at 800 and 1500$^\circ$C.

Table 1. Magnetic parameters for different Ca- and Mg-doped zirconia samples.

<table>
<thead>
<tr>
<th>Sample</th>
<th>$T = 800$ $^\circ$C</th>
<th>$T = 1200$ $^\circ$C</th>
<th>$T = 1500$ $^\circ$C</th>
<th>$T = 800$ $^\circ$C</th>
<th>$T = 1200$ $^\circ$C</th>
</tr>
</thead>
<tbody>
<tr>
<td>$Zr_{0.84}Ca_{0.16}O_2$</td>
<td>0.0335</td>
<td>0.0076</td>
<td>0.0055</td>
<td>0.012</td>
<td>0.005</td>
</tr>
<tr>
<td>$Zr_{0.86}Mg_{0.14}O_2$</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

$M_s$ in emu g$^{-1}$ (at 0.5 T) | 200  | 200  | 200  | 185  | 25    |

Coercivity (Oe) | 200  | 200  | 200  | 185  | 25    |

due to the presence of some oxygen vacancies in our samples. The density of oxygen vacancies is strongly dependent on the synthesis methods [24]. Zirconyl oxychloride was used as the zirconium precursor, so there is excess chlorine (Cl$_2$) during the sintering process, which was reported in an old study [24], which showed that preparation by nitrate or oxychloride precursors leads to oxygen vacancies in zirconia; however the vacancies are lower in the samples prepared by oxychloride precursors. This is confirmed from the weak ferromagnetic signal in $M$–$H$ measurements (figure 4) due to these oxygen vacancies; however, the oxygen vacancy concentration was not enough to result in long-range ferromagnetic ordering in these undoped samples.

Figure 5 shows the $M$–$H$ curves measured at room temperature (300 K) for the $Zr_{0.84}Ca_{0.16}O_2$ bulk samples annealed at 800, 1200 and 1500$^\circ$C/3 h in air. The magnetization decreases with increase in the sintering temperature, whereas the coercivity does not change noticeably. Saturation magnetization is six times larger for the sample annealed at 800$^\circ$C, as compared with the sample treated at 1500$^\circ$C. These results suggest that vacancies present at lower temperatures enhance the ferromagnetism, which diminishes on high-temperature treatments. The decrease in oxygen vacancies on high-temperature treatments results in the lowering of the ferromagnetic order and magnetic moment. There are more vacancies at 800$^\circ$C, due to the mixed phase (tetragonal phase as an additional phase), also reported in another study [25]. The decrease in oxygen vacancies on high-temperature treatments are also observed in other studies conducted for photoluminescence [26, 27]. The inset shows the $M$–$H$ loops of the Ca- and Mg-doped ZrO$_2$ samples annealed in a H$_2$/argon environment. In order to examine the defect nature of magnetism, annealing in different environments was performed, but even annealing in H$_2$/Ar
environment could not enhance the long-range ferromagnetic ordering at high temperatures, as expected due to the increasing number of oxygen vacancies. The temperature dependence of magnetization for these samples was also measured in the temperature range 10–350 K (figures not included); it was almost constant and did not show any transition in this temperature range.

Figure 6 shows the dependence of magnetization on the magnetic field at room temperature for \( \text{Zr}_{0.84}\text{Ca}_{0.16}\text{O}_2 \) thin films, grown on silicon substrates with different oxygen pressures. The ferromagnetic ordering is quite weak for samples grown at oxygen partial pressures of \( 10^{-2} \) and \( 10^{-3} \) mbar, whereas the film grown at an oxygen partial pressure of \( 10^{-4} \) mbar shows ferromagnetic character. This indicates that the film grown at lower oxygen partial pressures has more oxygen vacancies, available for ferromagnetic ordering. This type of oxygen partial pressure dependence was also observed in doped \( \text{ZnO} \) and \( \text{SnO}_2 \) oxide thin films by Hong et al., and in \( \text{CeO}_2 \) by Singhal et al. [28, 29]. There are often significant differences between the properties of bulk samples and thin films due to the effects of the substrate; the magnetic moments are quite low in the thin film samples, as expected. The magnetization does not saturate due to the dominating diamagnetic signal from the silicon substrate, but the value of spontaneous magnetization (\( M \)) ~ \( 2 \times 10^{-6} \text{emu g}^{-1} \) (at 2000 Oe) and the coercivity is around 80 Oe, and those values are quite low as compared with bulk values (see table 1).

Usually, bulk \( \text{ZrO}_2 \) is diamagnetic at room temperature. When \( \text{Ca}^{2+} \) or \( \text{Mg}^{2+} \) ions are substituted for zirconium ions (\( \text{Zr}^{4+} \)) sites, compensating anionic vacancies are created in the \( \text{O}^{2-} \) sublattice. These anionic vacancies could be the origin of ferromagnetism in non-magnetic divalent ion doped \( \text{ZrO}_2 \). This type of defect induced magnetism has already been observed in thin films of undoped \( \text{HfO}_2 \), \( \text{TiO}_2 \) [12, 30] and many other nanoparticles [31, 32], usually found in thin films and nanoparticles due to surface effects. However, this type of ferromagnetism in our bulk samples is robust and repeatable (even after months), because the samples are highly crystalline cubic zirconia, obtained on heating at very high temperatures. High-temperature treatments and larger grains ruled out the possibilities of hygroscopic nature and ageing, which have been observed in our recent study on Mn-doped zirconia powders due to low-temperature treatments and nanosized grains [17].

4. Conclusions

In conclusion, we have observed room-temperature ferromagnetism in Ca and Mg stabilized zirconia bulk samples and similar thin film oriented in [111] direction. X-ray diffraction studies and Raman spectra measured at room temperature reveal the formation of cubic phase zirconia. Bulk powders show good ferromagnetic hysteresis loops, whereas it is weaker in thin films. The origin of the ferromagnetism can be related to oxygen vacancies created due to divalent calcium and magnesium ion substitution for tetravalent zirconium ions.

Acknowledgments

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References


Figure 6. \( M-H \) loops measured (room temperature) for the thin films of \( \text{Zr}_{0.84}\text{Ca}_{0.16}\text{O}_2 \) samples grown at different oxygen pressures.
[31] Sundaresan A and Rao C N R 2009 Nano Today 4 96